


<b>Search Notes</b>  	<b>Application/Control No.</b>  10570594	<b>Applicant(s)/Patent Under Reexamination</b>  TAKATOH ET AL.
	<b>Examiner</b>  Pande, Suchira	<b>Art Unit</b>  1637

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

<b>SEARCH NOTES</b>		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
STN Structure done by STIC	2007/09/10	SP
PALM Inventor name search	2007/09/10	SP
Science Direct	2007/08/01	SP

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>